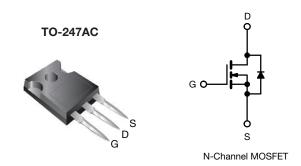
Vishay Siliconix

RoHS

COMPLIANT

HALOGEN FREE

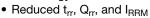
EF Series Power MOSFET With Fast Body Diode



PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	650				
R _{DS(on)} typ. (Ω) at 25 °C	V _{GS} = 10 V 0.0355				
Q _g max. (nC)	410				
Q _{gs} (nC)	38				
Q _{gd} (nC)	99				
Configuration	Single				

FEATURES

Fast body diode MOSFET using E series technology



- Low figure-of-merit (FOM) Ron x Qa
- Low switching losses due to reduced Q_{rr}
- Ultra low gate charge (Qa)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity lighting (HID)
 - Light emitting diodes (LEDs)
- · Consumer and computing
 - ATX power supplies
- Industrial
 - Welding
- Battery chargers
- Renewable energy
 - Solar (PV inverters)
- Switching mode power supplies (SMPS)
- Applications using the following topologies
 - LLC
 - Phase shifted bridge (ZVS)
 - 3-level inverter
 - AC/DC bridge

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free and halogen-free	SiHG70N60AEF-GE3

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	600	
Gate-source voltage			.,	± 20	V
Gate-source voltage AC (f > 1 Hz)			V_{GS}	30	
Continuous drain augrent (T. – 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I _D	60	
Continuous drain current (T _J = 150 °C)	V _{GS} at 10 V			38	Α
Pulsed drain current ^a			I _{DM}	173	
Linear derating factor				3.3	W/°C
Single pulse avalanche energy b			E _{AS}	1019	mJ
Maximum power dissipation			P_{D}	417	W
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C
Drain-source voltage slope $T_J = 125 ^{\circ}\text{C}$		C	al / alk	70	V/ns
Reverse diode dv/dt ^d			dv/dt	50	V/IIS
Soldering recommendations (peak temperature) ^c	For 10 s	1		300	°C

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. $V_{DD} = 140 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 28.2 \,\text{mH}$, $R_g = 25 \,\Omega$, $I_{AS} = 8.5 \,\text{A}$
- c. 1.6 mm from case
- d. $I_{SD} = 35 \text{ A}$, $di/dt = 300 \text{ A/}\mu\text{s}$, $V_{DS} = 400 \text{ V}$



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THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum junction-to-ambient	R _{thJA}	-	40	°C/W	
Maximum junction-to-case (drain)	R_{thJC}	-	0.3	G/ V V	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	600	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.62	-	V/°C
Gate-source threshold voltage (N)	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = 250 μA	2	-	4	V
Gate-source leakage	I _{GSS}	,	$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zero gate voltage drain current	I _{DSS}		480 V, V _{GS} = 0 V	-	-	1 2	μA mA
Drain-source on-state resistance	D	$V_{DS} = 480 \text{ V}$ $V_{GS} = 10 \text{ V}$, V _{GS} = 0 V, T _J = 125 °C I _D = 35 A	-	0.0355	0.041	Ω
Forward transconductance ^a	R _{DS(on)}		= 30 V, I _D = 35 A	-	23	0.041	S
	9 _{fs}	V _{DS}	= 30 V, I _D = 35 A		23	_	٥
Dynamic				<u> </u>	5040	I	ı
Input capacitance	C _{iss}	╡ ,	$V_{GS} = 0 V,$		5348	-	-
Output capacitance	C _{oss}	-	V _{DS} = 100 V, f = 1 MHz	_	238	-	-
Reverse transfer capacitance	C _{rss}	1 - 1 101112		-	7	-	pF
Effective output capacitance, energy related ^a	$C_{o(er)}$	V _{DS} = 0 V to 480 V, V _{GS} = 0 V		-	159	-	
Effective output capacitance, time related ^b	$C_{o(tr)}$	VDS - 0	V _{DS} = 0 V to 460 V, V _{GS} = 0 V		810	-	
Total gate charge	Qg			-	205	410	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 35 \text{ A}, V_{DS} = 480 \text{ V}$		38	-	nC
Gate-drain charge	Q _{gd}				99	-	
Turn-on delay time	t _{d(on)}			-	45	90	
Rise time	t _r	V _{DD} =	$V_{DD} = 480 \text{ V}, I_D = 35 \text{ A}, V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$		104	208	
Turn-off delay time	t _{d(off)}				219	438	ns
Fall time	t _f	1		-	113	226	
Gate input resistance	Rq	f = 1	MHz, open drain	0.5	1.0	2.0	Ω
Drain-Source Body Diode Characteristic	s						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	60	
Pulsed diode forward current	I _{SM}			-	-	173	A
Diode forward voltage	V _{SD}	T _{.1} = 25 °C	C, I _S = 35 A, V _{GS} = 0 V	-	0.9	1.2	V
Reverse recovery time	t _{rr}			-	184	368	ns
Reverse recovery charge	Q _{rr}		$5 ^{\circ}\text{C}$, $I_F = I_S = 35 \text{A}$,	-	1.6	3.2	иC
Reverse recovery current	I _{RRM}	di/dt = 100 A/μs, V _R = 400 V			16	-	A

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

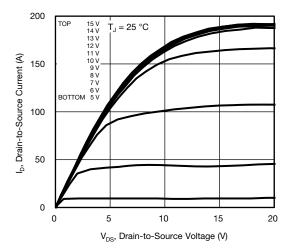


Fig. 1 - Typical Output Characteristics

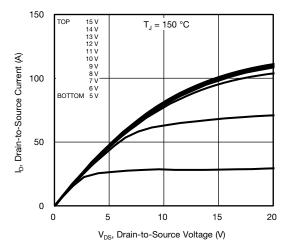


Fig. 2 - Typical Output Characteristics

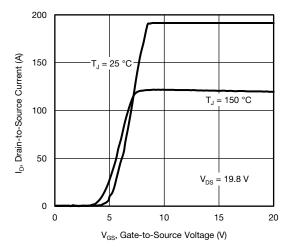


Fig. 3 - Typical Transfer Characteristics

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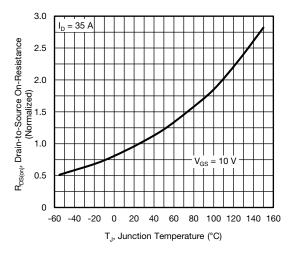


Fig. 4 - Normalized On-Resistance vs. Temperature

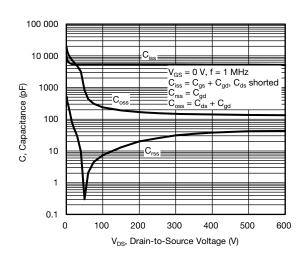


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

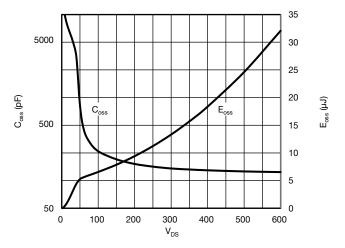


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



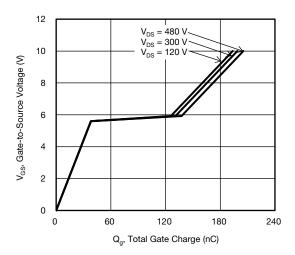


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

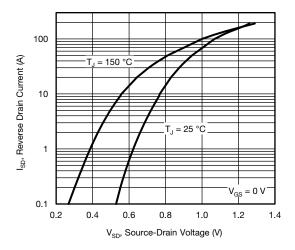


Fig. 8 - Typical Source-Drain Diode Forward Voltage

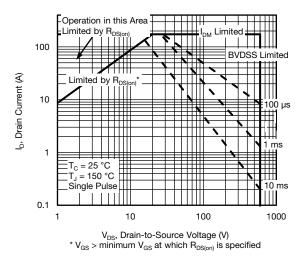


Fig. 9 - Maximum Safe Operating Area

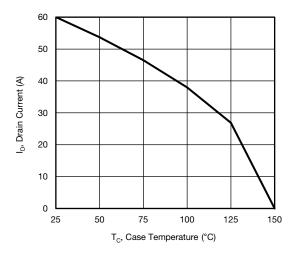


Fig. 10 - Maximum Drain Current vs. Case Temperature

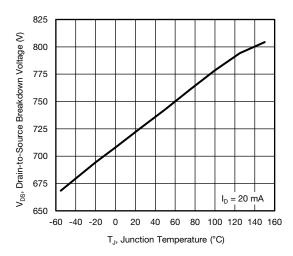


Fig. 11 - Temperature vs. Drain-to-Source Voltage



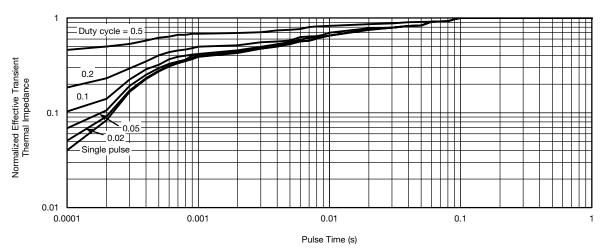


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

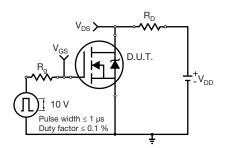


Fig. 13 - Switching Time Test Circuit

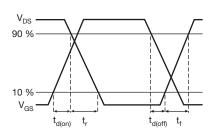


Fig. 14 - Switching Time Waveforms

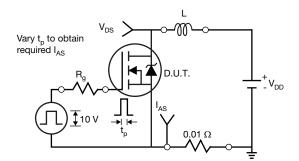


Fig. 15 - Unclamped Inductive Test Circuit

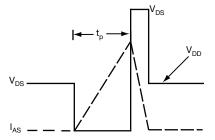


Fig. 16 - Unclamped Inductive Waveforms

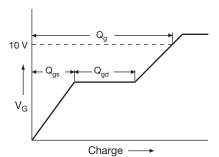


Fig. 17 - Basic Gate Charge Waveform

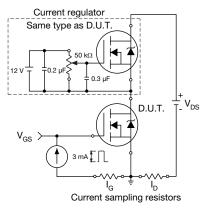
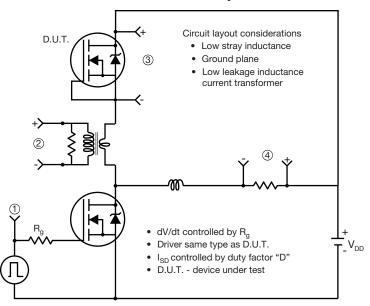


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



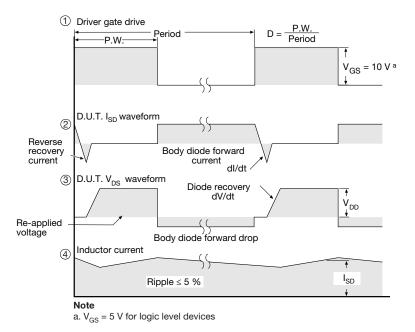


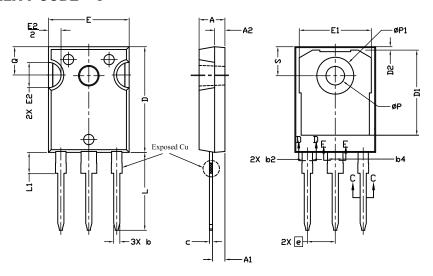
Fig. 19 - For N-Channel

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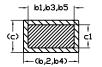


TO-247AC (High Voltage)

VERSION 1: FACILITY CODE = 9







Section C--C,D--D,E--E

	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.83	5.21	
A1	2.29	2.55	
A2	1.50	2.49	
b	1.12	1.33	
b1	1.12	1.28	
b2	1.91	2.39	6
b3	1.91	2.34	
b4	2.87	3.22	6, 8
b5	2.87	3.18	
С	0.55	0.69	6
c1	0.55	0.65	
D	20.40	20.70	4

	MILLIN		
DIM.	MIN.	MAX.	NOTES
D1	16.25	16.85	5
D2	0.56	0.76	
E	15.50	15.87	4
E1	13.46	14.16	5
E2	4.52	5.49	3
е	5.44	BSC	
L	14.90	15.40	
L1	3.96	4.16	6
ØР	3.56	3.65	7
Ø P1	7.19		
Q	5.31	5.69	
S	5.54	5.74	

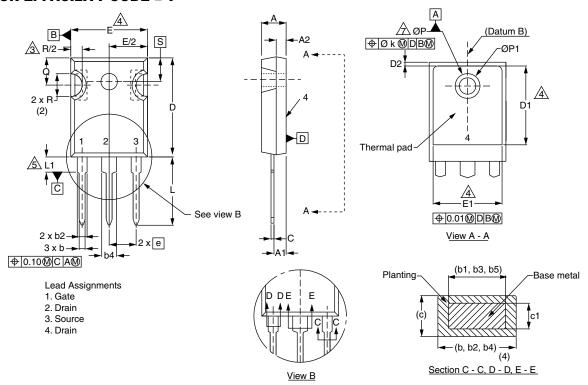
Notes

- (1) Package reference: JEDEC® TO247, variation AC
- (2) All dimensions are in mm
- (3) Slot required, notch may be rounded
- (4) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outermost extremes of the plastic body
- (5) Thermal pad contour optional with dimensions D1 and E1
- (6) Lead finish uncontrolled in L1
- $^{(7)}$ Ø P to have a maximum draft angle of 1.5° to the top of the part with a maximum hole diameter of 3.91 mm
- (8) Dimension b2 and b4 does not include dambar protrusion. Allowable dambar protrusion shall be 0.1 mm total in excess of b2 and b4 dimension at maximum material condition

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VERSION 2: FACILITY CODE = Y



	MILLIM	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.58	5.31	
A1	2.21	2.59	
A2	1.17	2.49	
b	0.99	1.40	
b1	0.99	1.35	
b2	1.53	2.39	
b3	1.65	2.37	
b4	2.42	3.43	
b5	2.59	3.38	
С	0.38	0.86	
c1	0.38	0.76	
D	19.71	20.82	
D1	13.08	-	

	MILLIN				
DIM.	MIN.	MAX.	NOTES		
D2	0.51	1.30			
Е	15.29	15.87			
E1	13.72	-			
е	5.46	BSC			
Øk	0.2	0.254			
L	14.20	16.25			
L1	3.71	4.29			
ØР	3.51	3.66			
Ø P1	-	7.39			
Q	5.31	5.69			
R	4.52	5.49			
S	5.51 BSC				
	•				

ECN: E19-0614-Rev. E, 08-Jan-2020

DWG: 5971

Notes

- (1) Dimensioning and tolerancing per ASME Y14.5M-1994
- (2) Contour of slot optional
- (3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body
- (4) Thermal pad contour optional with dimensions D1 and E1
- (5) Lead finish uncontrolled in L1
- (6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")
- (7) Outline conforms to JEDEC outline TO-247 with exception of dimension c



Legal Disclaimer Notice

Vishay

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